Search Notes

Application/Control	No. Applicant(s) Reexaminat	/Patent under ion
10/766,142	BANERJEE	ET AL.
Examiner	Art Unit	
John Rivell	3753	

SEARCHED						
Class	Subclass	Date	Examiner			
137	587 588 808 812	1/24/2006				
123	516	1/24/2006	(1)			
141	59 286 290	1/24/2006	PR .			
220	86.2	1/24/2006	1 Ch			
All	Updated	7/20/2000	YX			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
None		1/24/2006	R	
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